

MOSFET – Power, Single N-Channel, TOLL

40 V, 300 A, 0.57 m Ω

NVBLS0D5N04C

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- Small Footprint (TOLL) for Compact Design
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Symbol	Parameter			Value	Unit
V _{DSS}	Drain-to-Source Voltage			40	V
V_{GS}	Gate-to-Source Voltage	Gate-to-Source Voltage			V
I _D	Continuous Drain		T _C = 25°C	300	Α
	Current $R_{\theta JC}$ (Notes 1, 3)	Steady	T _C = 100°C	300	
P _D	Power Dissipation	State	T _C = 25°C	198.4	W
	R _{θJC} (Note 1)		T _C = 100°C	97.4	
I _D	Continuous Drain		T _A = 25°C	65	Α
	Current R _{0JA} (Notes 1, 2, 3)	Steady	T _A = 100°C	46	
P _D	Power Dissipation State		T _A = 25°C	4.3	W
	R _{θJA} (Notes 1, 2)		T _A = 100°C	2.1	
I _{DM}	Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	4700	Α
T _J , T _{stg}	Operating Junction and Storage Temperature Range			-55 to +175	ç
I _S	Source Current (Body Diode)			170	Α
E _{AS}	Single Pulse Drain-to-Source Avalanche Energy ($I_{L(pk)} = 55 \text{ A}$, L = 1 mH)			1512	mJ
TL	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

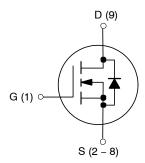
Symbol	Parameter		Unit
$R_{\theta JC}$	Junction-to-Case - Steady State	0.77	°C/W
$R_{\theta JA}$	Junction-to-Ambient - Steady State (Note 2)	35	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted. Current is limited by bondwire configuration.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	0.57 m Ω @ 10 V	300 A



H-PSOF8L CASE 100CU



N-CHANNEL MOSFET

ORDERING INFORMATION

Device	Package	Shipping [†]
NVBLS0D5N04CTXG	H-PSOF8L (Pb-Free)	2000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

Table 1. ELECTRICAL CHARACTERISTICS (T. = 25°C unless otherwise noted)

Symbol	Parameter	Test Cond	Test Conditions		Тур	Max	Units
OFF CHAR	ACTERISTICS						
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	I _D = 250 μA, \	$I_D = 250 \mu A, V_{GS} = 0 V$				V
V _{(BR)DSS} /T _J	Drain-to-Source Breakdown Voltage Temperature Coefficient				21.3		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 40 V, V _{GS} = 0 V	$T_J = 25^{\circ}C$			1	μΑ
			T _J = 175°C			1	mA
I _{GSS}	Gate-to-Source Leakage Current	V _{DS} = 0 V, V _{GS} =	= +20/-16 V			±100	nA
ON CHARA	ACTERISTICS (Note 4)						
V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D}$	= 475 μΑ	2	2.8	4	V
V _{GS(th)} /T _J	Threshold Temperature Coefficient				-7.4		mV/°C
R _{DS(on)}	Drain-to-Source On Resistance	V _{GS} = 10 V, I	_D = 50 A		0.5	0.57	mΩ
CHARGES	CAPACITANCES & GATE RESISTANCE				•		•
C _{iss}	Input Capacitance	V _{GS} = 0 V, V _{DS} = 25 V, f = 1 MHz			12600		pF
C _{oss}	Output Capacitance		- -		6705		pF
C _{rss}	Reverse Transfer Capacitance				227		pF
Rg	Gate Resistance	V _{GS} = 0.5 V, f = 1 MHz			1.8		Ω
Q _{G(tot)}	Total Gate Charge	V _{GS} = 10 V, V _{DS} =	V _{GS} = 10 V, V _{DS} = 20 V, I _D = 50 A		185		nC
Q _{G(th)}	Threshold Gate Charge	V _{GS} = 0 t	o 2 V		22		nC
Q _{gs}	Gate-to-Source Gate Charge	V _{DD} = 32 V, I	V _{DD} = 32 V, I _D = 50 A		48		nC
Q _{gd}	Gate-to-Drain "Miller" Charge				38		nC
V _{GP}	Plateau Voltage				4.2		V
SWITCHIN	G CHARACTERISTICS (Note 5)			•			•
t _{d(on)}	Turn-On Delay Time	V _{GS} = 10 V, V _I I _D = 50 A, R _G	_{DD} = 20 V,		40		ns
t _r	Turn-On Rise Time	$I_D = 50 \text{ A}, \text{ H}_G$	iEN = 6 Ω		84		ns
t _{d(off)}	Turn-Off Delay Time				164		ns
t _f	Turn-Off Fall Time		1		81		ns
DRAIN-SO	URCE DIODE CHARACTERISTICS			•			•
V _{SD}	Source-to-Drain Diode Voltage	I _{SD} = 50 A, V	' _{GS} = 0 V		0.76	1.2	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } dI_{S}/d_{t}$	= 100 A/μs,		108		ns
ta	Charge Time	I _S = 50	I _S = 50 A		62		ns
t _b	Discharge Time				46		ns
Q _{rr}	Reverse Recovery Charge	1			288		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300 \ \mu s$, duty cycle $\leq 2\%$.

^{5.} Switching characteristics are independent of operating junction temperatures

TYPICAL CHARACTERISTICS

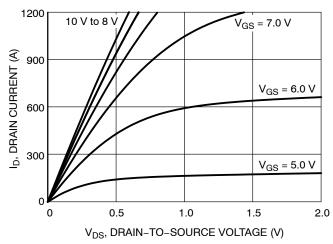
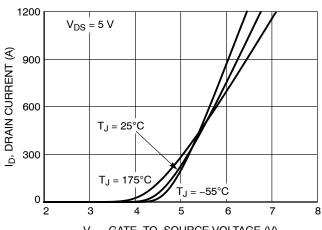


Figure 1. On-Region Characteristics



V_{GS}, GATE-TO-SOURCE VOLTAGE (V) Figure 2. Transfer Characteristics

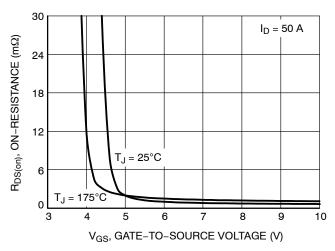


Figure 3. On-Resistance vs. Gate-to-Source Voltage

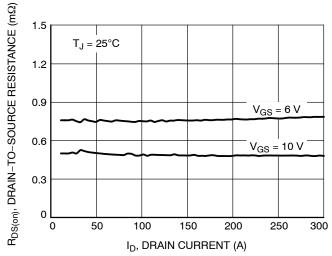


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

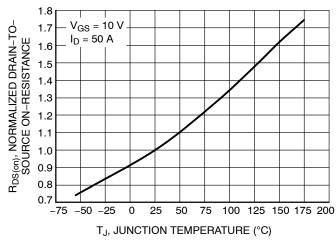


Figure 5. On–Resistance Variation with Temperature

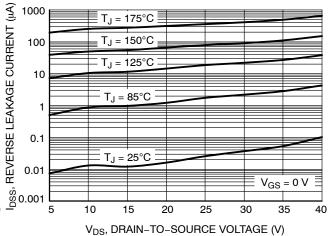


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS (continued)

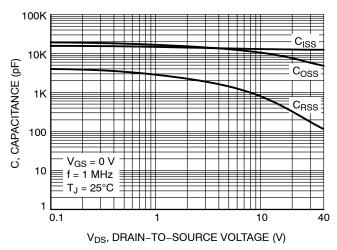


Figure 7. Capacitance Variation

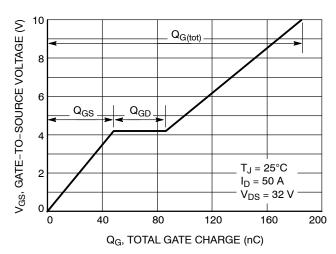


Figure 8. Gate-to-Source Voltage vs. Total Charge

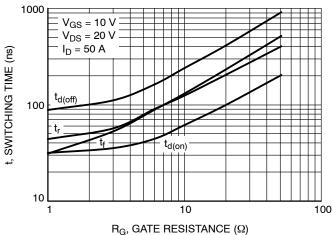


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

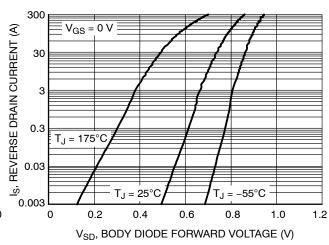


Figure 10. Diode Forward Voltage vs. Current

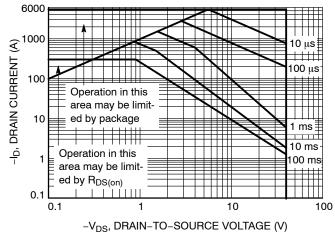


Figure 11. Forward Biased Safe Operating Area

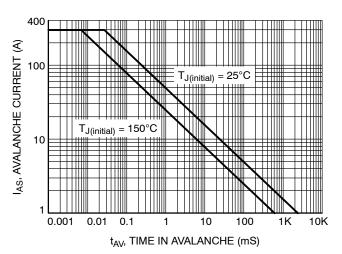


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS (continued)

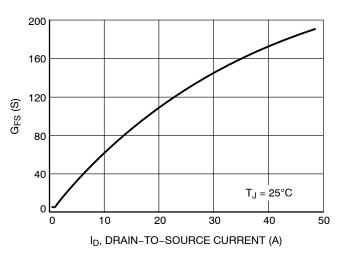


Figure 13. G_{FS} vs. I_D

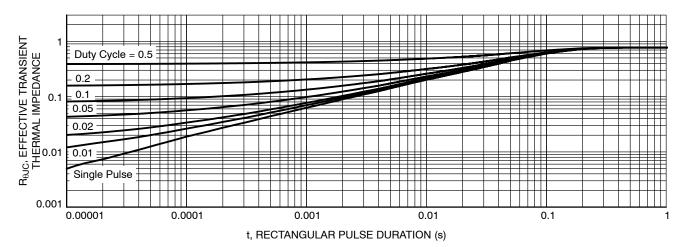


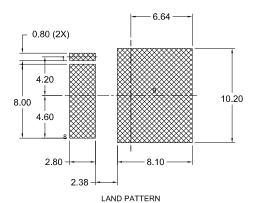
Figure 14. Transient Thermal Impedance



В (2x) a ccc D2 (2x) TERMINAL 1 CORNER Α INDEX AREA <u>5</u> (DATUM A) b (8x) bbbM C A B D4 (2x) E2 (2x) ddd(M) C L2 (8x) ·L1 🙆 SECTION "A-A" TOP VIEW DETAIL "B" η(4X) Θ // aaa C SIDE VIEW D1 DETAIL "B" SCALE: 2X D5 (2x) D6 D3 (2x) (2x)L3 (DATUM A) F6 (3x)E1 E3 E4 F5 √ b2 (8x)

H-PSOF8L 11.68x9.80x2.30, 1.20P CASE 100CU **ISSUE F**

DATE 30 JUL 2024



RECOMMENDATION *FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

NOTES:

HATCHED AREA

SCALE: 2X

- 1. PACKAGE STANDARD REFERENCE: JEDEC MO-299, ISSUE B.
- 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
- 3. "e" REPRESENTS THE TERMINAL PITCH.
- 4. THIS DIMENSION INCLUDES ENCAPSULATION THICKNESS "A1", AND PACKAGE BODY THICKNESS, BUT DOES NOT INCLUDE ATTACHED FEATURES, e.g., EXTERNAL OR CHIP CAPACITORS. AN INTEGRAL HEATSLUG IS NOT CONSIDERED AS ATTACHED FEATURE. 5. A VISUAL INDEX FEATURE MUST BE LOCATED WITHIN THE
- 6. DIMENSIONS b1,L1,L2 APPLY TO PLATED TERMINALS.
- 7. THE LOCATION AND SIZE OF EJECTOR MARKS ARE OPTIONAL.
 8. THE LOCATION AND NUMBER OF FUSED LEADS ARE OPTIONAL.

DIM	MILLIMETERS				
	MIN.	NOM.	MAX.		
Α	2.20	2.30	2.40		
A1	1.70	1.80	1.90		
b	0.70	0.80	0.90		
b1	9.70	9.80	9.90		
b2	0.35	0.45	0.55		
С	0.40	0.50	0.60		
D	10.28	10.38	10.48		
D/2	5.09	5.19	5.29		
D1	10.98	11.08	11.18		
D2	3.20	3.30	3.40		
D3	2.60	2.70	2.80		
D4	4.45	4.55	4.65		
D5	3.20	3.30	3.40		
D6	0.55	0.65	0.75		
E	9.80	9.90	10.00		
E1	7.30	7.40	7.50		
E2	0.30	0.40	0.50		
E3	7.40	7.50	7.60		
E4	8.20	8.30	8.40		

DIM	MILLIMETERS			
D _{II} VI	MIN.	NOM.	MAX.	
E5	9.36	9.46	9.56	
E6	1.10	1.20	1.30	
E7	0.15	0.18	0.21	
е		1.20 BSC	;	
e/2	(0.60 BSC	;	
Н	11.58	11.68	11.78	
H/2	5.74	5.84	5.94	
H1		7.15 BSC	;	
L	1.90	2.00	2.10	
L1	0.60	0.70	0.80	
L2	0.50	0.60	0.70	
L3	0.70	0.80	0.90	
θ	10° REF			
θ1	10° REF			
aaa	0.20			
bbb	0.25			
ccc	0.20			
ddd	0.20			
eee	0.10			

GENERIC MARKING DIAGRAM*

HEAT SLUG TERMINAL

Α = Assembly Location

BOTTOM VIEW

D/2

= Year

<u>/8</u>\

L (8x)

(DATUM B)

WW = Work Week

= Assembly Lot Code XXXX = Specific Device Code

AYWWZZ XXXXXXX XXXXXXX

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	H-PSOF8L 11.68x9.80x2.30, 1.20P		PAGE 1 OF 1	

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